

**Search Notes**

Application/Control No.

10/816,860

Examiner

Richale L. Haney

Applicant(s)/Patent under  
Reexamination

SHIN, SUNG SU

Art Unit

3765

**SEARCHED**

Class	Subclass	Date	Examiner
2	181	7/25/2005	RLH
2	171	07/22/2005	RLH
2	200.1	07/22/2005	RLH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See East report	7/25/2005	RLH